Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination TAKAYAMA ET AL.	
10/797,063		
Examiner	Art Unit	
Christopher P. Bruenjes	1772	

SEARCHED						
Class	Subclass	Date	Examiner			
428	36.9, 473.5, 421	2/28/2006	СВ			
399	321, 329	2/28/2006	СВ			
:						

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
INVENTOR NAME SEARCH (PALM)	2/28/2006	СВ
EAST (SEE PRINT OUT)	2/28/2006	СВ
		7.
·		